Application/Control No. Applicant(s)/Patent Under Reexamination DERDERIAN ET AL Examiner Thao P Le Applicant(s)/Patent Under Reexamination DERDERIAN ET AL And Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0024387	09-2001	Raaijmakers et al.	365/200
	В	US-			
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